



TestForum 2008

Nordic Hotel Forum, Tallinn, Estonia
November 25th & 26th, 2008

Call for Papers / Presentations

NTF Chairman:

Knut Båttstøløkken,
Kitron

Financial Chair:

Birger Schneider,
MicroLEX Systems

Secretary Chair:

Bjørn B Larsen,
NTNU

Executive Committee Members:

Knut Båttstøløkken,
Kitron

Birger Schneider,
MicroLEX Systems

Bjørn B Larsen,
NTNU

Stig-Gunnar Jensen,
Flextronics International

Bengt Magnhagen,
Elektronikindustriföreningen

Artur Jutman,
Tallinn University of Technology

Mick Austin,
JTAG Technologies Finland

Jukka Antila,
Nokia Siemens Networks

Jürgen Sedlacek,
Alvetec KonTest

Tauno Jokinen,
University of Oulu

The 2 day TestForum 2008, the 9th event in the series, is a major event for Test professionals in the Nordic area and Baltic states. The event is attended by key persons in the industry as well as International providers of test and measurement equipment and solutions.

The event will take place at Nordic Hotel Forum (<http://www.nordichotels.eu>), which is located in the downtown of Tallinn nearby its medieval historic center.

Nordic Test Forum hereby cordially invites you to participate and submit your contribution to TestForum 2008, which includes (but is not limited to) the following topics:

- *Embedded Test*
- *Functional test*
- *AOI / AXI*
- *Test economics*
- *ICT / Flying Probe*
- *Boundary scan test*
- *Preventive test / Prognostics*
- *Best practices in manufacturing test*
- *ASIC: BIST / Mixed-signal / IDDQ / IDDT*
- *Board test SW, BIST, diagnostics*
- *Testing Lead Free Electronics*
- *Design to Test transfer / Design for Testing*
- *Data acquisition / collection / analysis*
- *Quality methods and tools*
- *ESD*
- *Test efficiency and optimization*
- *Future technology trends and test challenges*
- *Data acquisition / collection / analysis*

Submissions

NTF seeks for full papers and/or presentations in the area of test of electronics, including *R&D, Application Contributions, Best Practices, Emerging Ideas*, etc. You are free to submit contributions outside the above topics as long as they stay within the field of electronics test. Focus shall be on new and upcoming challenges, opportunities and techniques rather than on particular products.

Proceedings

At the event, Nordic Test Forum will deliver a CD-ROM of the accepted contributions whose authors wish to provide the corresponding materials.

The Format of the Event

- The event duration will be a two-day symposium and small exhibition attached to it.
- November 24th on the evening there is the AGM of the NTF.
- The mix of presentations will decide the number of sessions.
- The presentations will be 30 minutes each; 25 minutes of speech and 5 minutes for questions/comments.
- During the event a small exhibition will take place where exhibitors will be exhibiting their latest equipment and be available for discussions.

Key Dates

- 1st draft proposal:
- Notification of acceptance:
- Presentation slides:

August 31st, 2008
September 30^h, 2008
October 31th, 2008

Further Information and Submissions

Suzanne Holte
MicroLEX Systems A/S
Dr Neergaards vej 5C
DK-2970 Hoersholm
Phone: +45 4576 2100
Email: sho@microlex.dk

Visit the NTF web page at:
<http://www.nordicestforum.org>

Sponsors of Nordic Test Forum.

